

<b>Notice of References Cited</b>	Application/Control No. 10/766,282		Applicant(s)/Patent Under Reexamination GUNTURI ET AL.	
	Examiner KAN YUEN		Art Unit 2616	Page 1 of 1

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*	B	US-7,177,279 B2	02-2007	Kataria, Deepak	370/235
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#### NON-PATENT DOCUMENTS

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